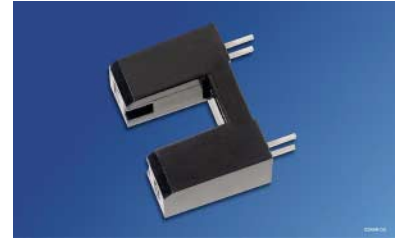


## Gabellichtschranke Slotted Interrupter

### SFH 9310



#### Wesentliche Merkmale

- Kompaktes Gehäuse
- GaAs-IR-Sendediode (950 nm)
- Si-Fototransistor mit Tageslichtsperrfilter

#### Features

- Compact type
- GaAs infrared emitter (950 nm)
- Silicon phototransistor detector with daylight-cutoff filter

#### Anwendungen

- Geschwindigkeitsüberwachung
- Motorsteuerung
- Überwachung des Papiervorschubs in Druckern, Kopier- und Faxgeräten
- Speicherlaufwerke
- Steuerung des Druckkopfes in Druckern
- Münzdetektion
- Optoelektronische Schalter

#### Applications

- Speed control
- Motor control
- Monitoring of paper feed in printers, copiers, facsimiles
- Disk drives
- Control of print head in printers
- Coin detection
- Optoelectronic switches

Typ Type	Bestellnummer Ordering Code	Gehäuse Package
SFH 9310	Q62702-P5214	Schwarzes Polycarbonat Plastikgehäuse, Anschlüsse im 2.54-mm Raster, Senderseite durch Buchstaben „E“, Empfängerseite durch Buchstaben „S“ gekennzeichnet, Kathode / Transistoremitter durch schräge Kante gekennzeichnet. Black polycarbonate plastic material housing, solder tabs 2.54-mm (1/10") spacing, emitter side marked with letter "E", sensor side marked with letter "S", cathode / emitter of transistor marked with edge at an angle.

Grenzwerte  $T_A = 25\text{ °C}$ **Maximum Ratings**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
<b>Sender (GaAs-Diode)</b> <b>Emitter (GaAs Diode)</b>			
Sperrspannung Reverse voltage	$V_R$	5	V
Durchlaßstrom Forward current	$I_{F(DC)}$	60	mA
Verlustleistung Power dissipation	$P_{tot}$	100	mW
Wärmewiderstand Thermal resistance	$R_{thJA}$	280	K/W

**Empfänger (Si-Fototransistor)****Detector (Silicon Phototransistor)**

Kollektor-Emitter-Spannung Collector-emitter voltage	$V_{CE}$	30	V
Kollektor-Emitter-Spannung, ( $t \leq 2\text{ min}$ ) Collector-emitter voltage, ( $t \leq 2\text{ min}$ )	$V_{CE}$	70	
Emitter-Kollektor-Spannung Emitter-collector voltage	$V_{EC}$	7	
Kollektorstrom Collector current	$I_C$	50	mA
Verlustleistung Total power dissipation	$P_{tot}$	150	mW
Wärmewiderstand Thermal resistance	$R_{thJA}$	280	K/W

**Gabellichtschranke****Slotted Interrupter**

Lagertemperatur Storage temperature range	$T_{stg}$	- 40 ... + 85	°C
Betriebstemperatur Operating temperature range	$T_{op}$	- 40 ... + 85	
Elektrostatische Entladung Electrostatic discharge	ESD	2	kV

Kennwerte  $T_A = 25\text{ °C}$ **Characteristics**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
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**Sender** (GaAs-Diode)**Emitter** (GaAs Diode)

Wellenlänge der Strahlung Wavelength of peak emission	$\lambda_{\text{peak}}$	950	nm
Durchlaßspannung Forward voltage $I_F = 20\text{ mA}$ , $t_p = 20\text{ ms}$	$V_F$	1.2 ( $\leq 1.4$ )	V
Sperrstrom Reverse current $V_R = 5\text{ V}$	$I_R$	0.01 ( $\leq 1$ )	$\mu\text{A}$
Kapazität Capacitance $V_R = 0\text{ V}$ , $f = 1\text{ MHz}$	$C_0$	16	pF

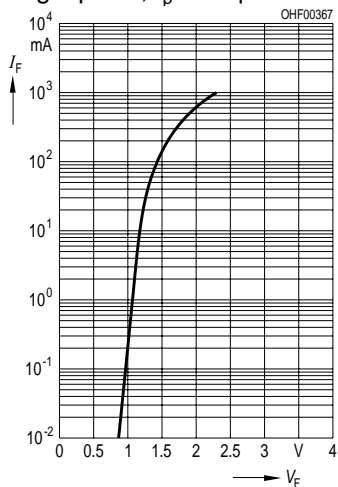
**Empfänger** (Si-Fototransistor)**Detector** (Silicon Phototransistor)

Wellenlänge der max. Fotoempfindlichkeit Wavelength of max. sensitivity	$\lambda_{S\text{ max}}$	920	nm
Spectr. Bereich der Fotoempfindlichkeit Spectral range of sensitivity $S = 10\%$ of $S_{\text{max}}$	$\lambda$	840 ... 1080	nm
Kapazität Capacitance $V_{CE} = 0\text{ V}$ , $f = 1\text{ MHz}$ , $E = 0$	$C_{CE}$	6.5	pF
Dunkelstrom Dark current $V_{CE} = 20\text{ V}$	$I_{CEO}$	2 ( $\leq 50$ )	nA

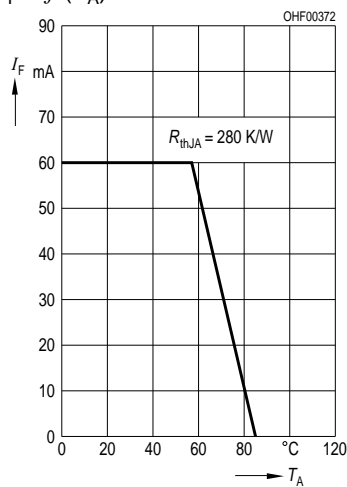
**Kennwerte**  $T_A = 25\text{ °C}$   
**Characteristics** (cont'd)

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
<b>Gabellichtschranke</b> <b>Slotted interrupter</b>			
Kollektor-Emitterstrom Collector-emitter current $I_F = 20\text{ mA}; V_{CE} = 5\text{ V}$	$I_{CE\text{ min.}}$ $I_{CE\text{ typ.}}$	> 0.7	mA
Kollektor-Emitter-Sättigungsspannung Collector-emitter-saturation voltage $I_F = 20\text{ mA}; I_C = 0.2\text{ mA}$	$V_{CE\text{ sat}}$	≤ 0.4	V
Anstiegs- und Abfallzeit Rise and fall time $V_{CC} = 5\text{ V}, I_C = 1\text{ mA}, R_L = 1\text{ k}\Omega$	$t_r$ $t_f$	13 17	$\mu\text{s}$ $\mu\text{s}$

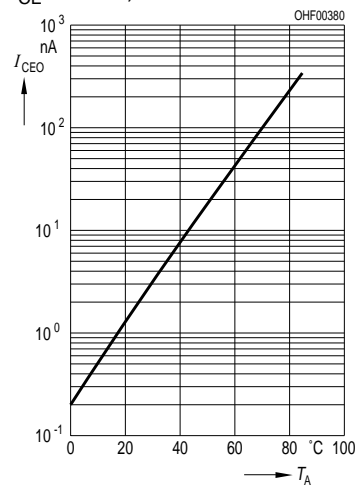
**Forward Current  $I_F = f(V_F)$**   
 Single pulse,  $t_p = 20 \mu s$



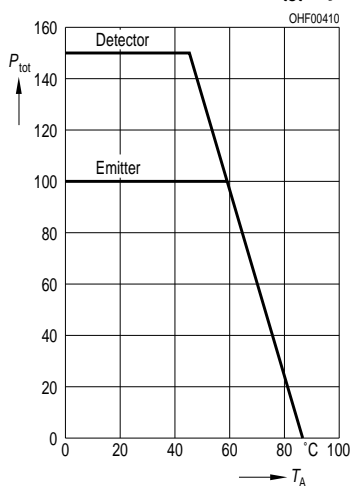
**Max. Permissible Forward Current  $I_F = f(T_A)$**



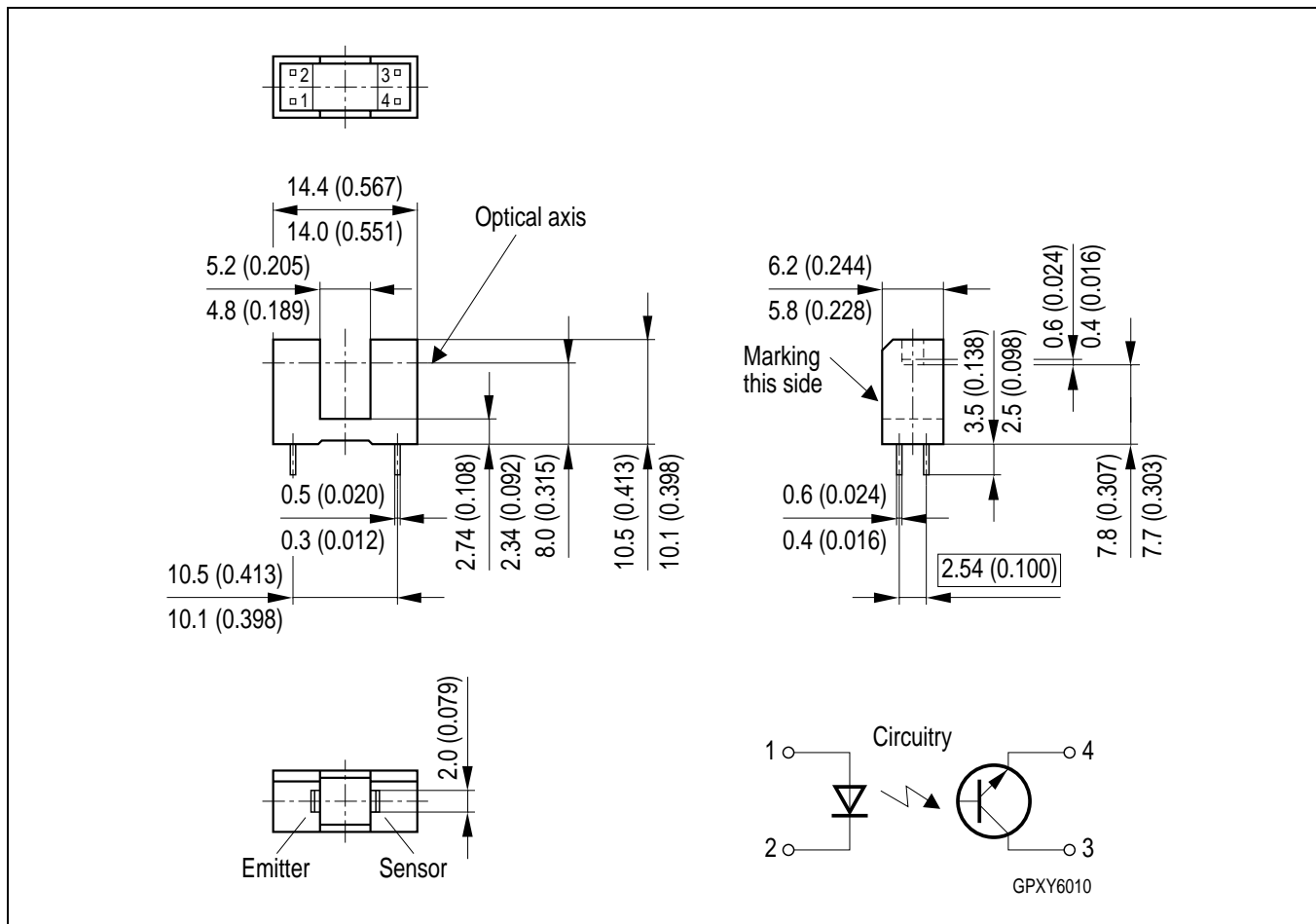
**Dark Current  $I_{CEO} = f(T_A)$**   
 $V_{CE} = 20 V, E = 0$



**Total Power Dissipation for Emitter and Detector  $P_{tot} = f(T_A)$**



Maßzeichnung  
Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

**Löthinweise**  
**Soldering Conditions**

Bauform Type	Tauch-, Schwalllötung Dip, Wave Soldering		Reflowlötung Reflow Soldering		Kolbenlötung Iron Soldering (Iron temp.)
	Peak Temp. (solderbath)	Max. Time in Peak Zone	Peak Temp. (package temp.)	Max. Time in Peak Zone	
SFH 9310	260 °C	10 s	n. a.	–	300 °C < 5 s

Published by OSRAM Opto Semiconductors GmbH & Co. OHG  
 Wernerwerkstrasse 2, D-93049 Regensburg  
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**Packing**

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

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